

AMENDMENTS TO THE CLAIMS:

If entered, this listing of claims will replace all prior versions and listings of claims in the application.

Listing of Claims:

1. (currently amended): A circuit, realizing a driver device for secure and reliable firing of an igniter or squib, connecting said squib via a high-side electronic switch to a power source and via a low-side electronic switch to circuit ground, incorporating separate power supply parts for high voltage and low voltage domains and equipped with elaborate intrinsic diagnostics and online testing features for circuit protection and operation securing purposes, comprising:

a means for control of said firing, said diagnostics, and said online testing having a safing sensor signal input pin, four pins for voltage sense input signals, four pins for two pairs of current control output signals, and a ground pin;

a means for said high-side switching of said squib to said power source performing high-side switching transistor functions for said firing, for said diagnostics, and for said online testing;

a means for said low-side switching of said squib to said circuit ground performing low-side switching transistor functions for said firing, for said diagnostics, and for said online testing;

a means for said high voltage domain power supply;

a means for said low voltage domain power supply;

a means for secured supply of electrical energy to said means for said high-side switching derived from said high voltage domain;

20 a means for ~~steered~~secured supply of ~~electrical energy~~currents to said means for said low-side switching derived from said low voltage domain and controlled by one pair of said current control output signals;

a means for steered supply of currents to a means for driving said high-side switching means derived from said low voltage domain and controlled by the other
25 pair of said current control output signals;

a means for driving said high-side switching means for said squib controlled by said means for control of firing, diagnostic and online testing and supplying drive current to said high-side switching means either for the case of said diagnostic and online testing operations or for the case of said firing operation; and

30 a means for connecting said high-side switching means and said low-side switching means to said means for control of firing, diagnostic and online testing in order to execute said diagnostic measurement and online testing by said four voltage sense input signals whereby in said case of diagnostic and online testing operations a switchable and controllable current flow is initiated in conjunction with
35 appropriate voltage measurements and resistance evaluations thereby strictly observing that no firing condition for said squib ~~are~~is allowed to occur and whereby in ~~said~~case of said firing operation a secure firing of said squib is always guaranteed.

2. (original): The circuit according to claim 1 wherein said means for said high-side switching of said squib to said power source connects to one side of said squib and said means for said low-side switching of said squib to said circuit ground connects to the other side of said squib, thus forming a switchable squib firing branch between said power source and said circuit ground.

3. (original): The circuit according to claim 1 wherein said means for control of said firing, said diagnostic and said online testing is subdivided into a means for control of said firing and a means for said diagnostic and online testing.

4. (original): The circuit according to claim 1 wherein said means for said high-side switching of said squib to said power source is realized as a controllable electronic switch in current mirror configuration.

5. (original): The circuit according to claim 4 wherein said current mirror configuration is driven by voltages not exceeding the high-voltage domain supply voltage, thus eliminating the need for an external and additional charge pump.

6. (original): The circuit according to claim 4 wherein said current mirror configuration is implemented using Field Effect Transistors (FETs).

7. (original): The circuit according to claim 6 wherein said FETs are of the PMOS type manufactured in CMOS technology.

8. (original): The circuit according to claim **7** wherein said FETs of the PMOS type and manufactured in CMOS technology are driven by voltages not exceeding the high-voltage domain supply voltage, thus eliminating the need for an external and additional charge pump.

9. (original): The circuit according to claim **1** wherein said means for said low-side switching of said squib to said circuit ground is implemented using a controllable electronic switch in current mirror configuration.

10.(original): The circuit according to claim **9** wherein said current mirror configuration is set up using Field Effect Transistors (FETs).

11.(original): The circuit according to claim **10** wherein said FETs are of the NMOS type manufactured in CMOS technology.

12. (currently amended): The circuit according to claim **1** wherein said means for said high voltage domain power supply include generators and batteries from a vehicle e.g. as primary source ~~(e.g. with a~~ voltage range of 15 V to 40V), and derived there-from separate secondary power sources implemented as charge pump devices operating in the same voltage range as said primary source.

13. (original): The circuit according to claim **12** wherein said means for said high voltage domain power supply also includes a controlled current source for said high-side switching device.

14. (currently amended): The circuit according to claim **1** wherein said means for said low voltage domain power supply consist of separate power sources derived from generators and batteries from a vehicle e.g. as primary source (e.g. with a voltage range of 15 V to 40V) and operating within a reduced low voltage range (e.g. in the range of 3.3 V to 5V).

15. (currently amended): The circuit according to claim **14** wherein said means for low voltage domain power supply also includes controlled current sources for said ~~low-side switching device~~.

16. (original): The circuit according to claim **1** wherein said means for secured supply of electrical energy to said means for said high-side switching derived from said high voltage domain consists of a charge pump feeding a controlled current source.

17. (currently amended): The circuit according to claim **1** wherein said means for ~~steered~~secured supply of electrical energy currents to said low-side switching means derived from said low voltage domain consists of ~~two~~one pair of controlled current sources fed by voltages out of said low voltage domain for controlled

5 current switching between different currents for current limiting and diagnostic testing purposes respectively.

18. (original): The circuit according to claim 1 wherein said means for driving said high-side switching means for said squib consists of a stacked current mirror circuit made up of four FETs serving as current source for said high-side switching device circuit implemented in CMOS technology.

19. (original): The circuit according to claim 1 wherein said means for connecting said high-side switching means and said low-side switching means to said means for control of firing, diagnostic and online testing comprises on one hand output control signal lines leading to said means for driving said high-side switching means and leading to said means for secured supply of electrical energy to said means for said low-side switching derived from said low voltage domain and on the other hand input measurement signal lines from said high-side switching means of said squib and from said low-side switching means, as well as power supply and ground connections.

20. (currently amended): The circuit, according to claim 1 whereby into said means for said high-side switching of said squib to said power source are combined together: firstly said high-side switching transistor functions for controlled firing operation and for onsite test diagnostics, secondly said controlled firing operation with current limitation and thirdly said onsite test diagnostics.

21. (currently amended): The circuit, according to claim 1 whereby into said means for said low-side switching of said squib to said circuit ground are combined together: firstly said low-side switching transistor functions for controlled firing operation and for onsite test diagnostics, secondly said controlled firing operation with current limitation and thirdly said onsite test diagnostics.

22. (currently amended): A circuit, realizing a driver device for secure and reliable firing of an igniter or squib, connecting said squib via an electronic high-side electronic-switch to a power source and via an electronic low-side electronic-switch to circuit ground, incorporating separate power supply parts for high voltage and low voltage domains and equipped with elaborate intrinsic diagnostic and online testing features for a diagnostics and a firing mode for circuit protection and firing operation securing purposes, comprising:

a control and test unit subdivided into a Firing Control (FC) part and a Diagnostic & Online Testing (DOT) part with two pairs of current control outputs for said diagnostics and said firing mode and each for said high-side and said low-side switch respectively;

two output terminal pins for external connecting the igniter or squib to said circuit;

a first controllable electronic switch, namely said high-side switch, connecting to one side of said squib and allowing for connecting said squib to said power source for safely performing driver switch diagnostics and a driver switch operation of secure firing when simultaneously closed with said low-side switch;

a second controllable electronic switch, namely said low-side switch,
 connecting to the other side of said squib and allowing for connecting said squib to
 20 circuit ground for safely performing said driver switch diagnostics and said driver
switch operation of secure firing when simultaneously closed with said high-side
switch;

one input connector pin for connecting an external mechanical safing
 sensor to said driver device fed by a charge pump which in turn is fed by said
 25 power source, which itself is also connected and reverse battery protected by a
 series power diode and thus serving as main power input terminal and therefore
 connected to one side of said high-side switch;

one input connector pin for connecting an electronic safing sensor to said
 control and test unit of said driver device;

30 one output connector pin for a 'Fuel Cut-Off' signal generated within said
 Firing Control (FC) part of said control and test unit in case of a firing operation;

one output connector pin for a 'Diagnostic Lamp Driver' signal generated
 within said Diagnostic & Online Testing (DOT) part of said control and test unit in
 case of a failure detection during normal operation of the circuit;

35 one first ground pin of the circuit wired to said low-side switch,
 one second ground pin of the circuit wired to said first ground pin and to
 said control and test unit,

~~one a first controlled~~ able current source with a diagnostics current control
input for driver switch diagnostics of said ~~first controllable electronic switching~~

40 ~~device, named high-side switch and switching on in current limited diagnostic~~
~~mode performing high-side switching transistor functions for diagnostics;~~

~~one a second controlled~~able current source with a firing current control input
for said driver switch operation of firing of ~~for said first controllable electronic~~
~~switching device, named high-side switch and switching on in current limited firing~~
45 ~~mode performing high-side switching transistor functions for firing;~~

one high-side current output connecting the current outputs of said first and
said second controlled current source as common input to said high-side switch;

~~one a third controlled~~able current source with a diagnostics current control
input for said driver switch diagnostics of said ~~second controllable electronic~~
50 ~~switch, named low-side switch and switching on in said current limited diagnostic~~
~~mode performing low-side switching transistor functions for diagnostics;~~

~~one a fourth controlled~~able current source with a firing current control input
for said driver switch operation of firing of ~~for said second controllable electronic~~
~~switch, named low-side switch and switching on in said current limited firing mode~~
55 ~~performing low-side switching transistor functions for firing;~~

one low-side current output connecting the current outputs of said third and
said fourth controlled current source as common input to said low-side switch;

one external power supplying component receiving input from said separate
power supply part out of said low voltage domain;

60 one external power supplying component working as charge pump fed by
said separate power supply part from said high voltage domain and feeding in
diagnostics mode said first controllable electronic switching device, realized as

current mirror and as well feeding an external energy storing device, realized as storage capacitor;

65 one break-through voltage enhanced, ~~i.e.~~ stacked current mirror circuit made up of four FETs serving as current source for said high-side switching device;

 one external power supplying component working as charge pump fed by said separate power supply part from said high voltage domain and feeding said
70 high-side current mirror;

 two low-side control signal lines from said current control outputs fed by said control and test unit steering said controlledable current source for said driver switch diagnostics and steering said controlledable current source for said driver switch operation of firing, both current sources used for said low-side switch;

75 two control signal lines from said current control outputs fed by said control and test unit steering said controlled current source for said driver switch diagnostics and steering said controlled current source for said driver switch operation of secure firing, both current sources used for said high-side switch; and

 four sensing-sense signal lines sensing the voltage levels on both sides of
80 said two controllable electronic switches and feeding their signals into said control and test unit in both operating cases: said diagnostic mode and said firing mode.

23. (original): The circuit according to claim **22** wherein said first controllable electronic switching device, named high-side switch is realized by a PMOS-FET current mirror circuit.

24. (original): The circuit according to claim **23** wherein said high-side switch realized by a PMOS-FET current mirror circuit is driven by voltages not exceeding the high-voltage domain supply voltage, thus eliminating the need for an external and additional charge pump.

25. (original): The circuit according to claim **22** wherein said first controllable electronic switching device, named high-side switch is realized by a PMOS-FET current mirror circuit and driven by said stacked current mirror circuit made up of four driver FETs serving as current source for said high-side switching device.

26. (original): The circuit according to claim **25** wherein said PMOS-FET current mirror circuit driven by said stacked current mirror circuit made up of four driver FETs serving as current source for said high-side switching device are all fed by voltages not exceeding the high-voltage domain supply voltage, thus eliminating the need for an external and additional charge pump.

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27. (original): The circuit, according to claim **22** wherein second controllable electronic switch, named low-side switch is implemented by two low-side driver NMOS-FETs in current mirror configuration and thus serving as said low-side driver switch.

28. (currently amended): The circuit, according to claim **22** whereby into said high-side switching device of said squib to said power source are combined together:

firstly said high-side switching transistor functions for controlled firing operation
and for onsite test diagnostics, secondly said controlled firing operation with
5 current limitation and thirdly said onsite test diagnostics.

29. (currently amended): The circuit, according to claim **22** whereby into said low-
side switching device of said squib to said circuit ground are combined together:
firstly said low-side switching transistor functions for controlled firing operation and
for onsite test diagnostics, secondly said controlled firing operation with current
5 limitation and thirdly said onsite test diagnostics.

30. (currently amended): The circuit, according to claim **22** implemented with said
controlled~~able~~ current source for said driver switch operation of firing ~~of~~ for said
high-side switch and with said controllable current source for said low-side switch,
both trimmed ~~i.e.~~ and setup in such a way, that the control currents for said current
5 sources are reduced to a safe minimum for a secure firing operation, thus allowing
for the smallest external storage capacitor possible.

31. (original): The circuit, according to claim **22** implemented as integrated circuit.

32. (original): The circuit, according to claim **22** implemented as integrated circuit
in low cost CMOS technology.

33. (currently amended): A method for controlled operation and secure firing of igniters or squibs, capable of driving the necessary switching devices within a circuit branch connecting said squib via a high-side electronic switch to a power source and via a low-side electronic switch to circuit ground, incorporating
5 separate power supply parts for high voltage and low voltage domains and equipped with elaborate intrinsic diagnostic and online testing features for circuit protection and operation securing purposes, altogether named Squib Driver circuit, comprising:

providing a means for a Control and Test Unit for said Squib Driver circuit,
10 containing a Firing Control (FC) unit and a Diagnostic and Online Test (DOT) unit with input and output connections for ~~inter alia~~ an electrical Safing Sensor, a Fuel Cut-Off During Collision operation and a Diagnostic Lamp Driver signal, and further additionally containing measuring or sensing input signals and control output signals;

15 providing for said Squib Driver circuit means for connecting an external main power supply via a mechanical Safing Sensor and means for connecting to ground;

providing for said Squib Driver circuit external means for said power supply using a single charge pump circuit for storing said main supply energy within an
20 external storage capacitor as Airbag Voltage Supply ~~so-called~~ (AVS) voltage;

providing for said Squib Driver circuit connection means for connecting an external igniter device or squib to a first connection pin named high-side connection and to a second connection pin named low-side connection;

providing a first internal means for switching operations of said external
25 igniter device or squib on its high-side connection point, named high-side switching
device;

providing a second internal means for switching operations of said external
igniter device or squib on its low-side connection point, named low-side switching
device;

30 providing another internal means for driving said internal high-side switching
device, named high-side driver circuit;

providing other internal means for supplying multiple driver currents to said
internal high-side driver circuit and/or high-side and low-side switching devices
using controllable and switchable current source circuits;

35 providing means for connection of said measuring or sensing input signals
from said high-side and low-side switching devices to said Control and Test Unit;

providing means for connection of said control output signals from said
Control and Test Unit to said controllable and switchable current source circuits for
said switch driver circuit and/or for said high-side and low-side switching devices;

40 implementing said high-side switching device with the help of a pair of
PMOS transistors in current mirror configuration, thus avoiding the need for an
extra and additional charge pump for an AVS excess driving voltage normally
needed for operating said high-side switching device;

45 implementing said low-side switching device with the help of a pair of
NMOS transistors in current mirror configuration;

implementing said high-side driver circuit as a break-through voltage enhanced, ~~i.e. stacked~~— current mirror circuit made up of four driver NMOS-FETs as controlled current source, again controlled by a pair of switchable current sources, whereby the one current source defines the normal diagnostic and test operations and the other current source the firing operation;

implementing for said low-side switching device said controlled pair of switchable current sources as drivers, whereby the one current source defines the normal diagnostic and test operations and the other current source the firing operation;

initiating a Basic Function Test Cycle for said Squib Driver circuit during power on of said Squib Driver circuit, testing regular functionality of said internal driver circuits and switches and said external igniter device or squib;

starting, in normal operation mode, the Diagnostic and Test Cycle for continuous surveillance of prescribed isolation and resistance values i.e. of the regular functioning of the system;

testing for isolation values of the high-side and low-side switching devices versus supply voltage and ground;

measuring appropriate test voltages at the squib and said high-side and low-side switching devices in the switched squib branch with the help of given diagnostic currents;

calculating the resistance of the squib and said high-side and low-side switching devices in the switched squib branch;

evaluating said measured and calculated values and compare to the prescribed and for a regular operation required and defined values;

70 activating in case of failure an alarming signal;

calculating with the help of said voltage and resistance values secure firing current values for said high-side and said low-side switching devices, thus trimming, ~~i.e.~~ and setting-up said controlled driving currents to their operational necessary minimum, and thus limiting said main supply energy stored within said external storage capacitor to an optimum;

75 continuing the Diagnostic and Test Cycle from its starting point above during normal operation of the Squib Driver circuit; and

firing the squib in case of emergency by switching on at the same time, both the high-side and the low-side switching devices and whilst observing given current limitations with the help of said controlled driving currents.

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34. (new): The circuit according to claim 1 wherein said means for steered supply of currents to a means for driving said high-side switching means derived from said low voltage domain consists of one pair of controlled current sources fed by voltages out of said low voltage domain for controlled current switching between different currents for current limiting and diagnostic testing purposes respectively.

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35. (new): The circuit according to claim 34 wherein one current source of said pair of controlled current sources is used in case of said diagnostic and online testing operations and the other current source is used in case of said firing operation and

each current source is being controlled by a separate case related current control input and whereby as current output from said pair of controlled current sources one common output is formed.

36. (new): The circuit according to claim 17 wherein one current source of said pair of controlled current sources is used in case of said diagnostic and online testing operations and the other current source is used in case of said firing operation and each current source is being controlled by a separate case related current control input and whereby as current output from said pair of controlled current sources one common output is formed.

37. (new): A circuit, realizing a driver device for secure and reliable firing of an igniter or squib, comprising:

an external power source delivering the main supply energy and as well feeding an external energy storing device, realized as a storage capacitor;

a high-side and a low-side switch, connecting said squib to said power source and to ground respectively and thus allowing safely performed diagnostics of switches and said squib and also guaranteeing a secure firing of said squib when simultaneously closed and whereby said high-side switch is implemented with the help of a pair of PMOS transistors and said low-side switch with the help of a pair of NMOS transistors both in current mirror configuration;

a first controlled current source for diagnostics and thus enabling to switch on in a current limited diagnostic mode said high-side switch;

a second controlled current source for firing and thus enabling to switch on in a current controlled firing mode said high-side switch;

15 a third controlled current source for diagnostics and thus enabling to switch on in said current limited diagnostic mode said low-side switch;

a fourth controlled current source for firing and thus enabling to switch on in said current controlled firing mode said low-side switch; and

20 a control circuit for diagnostics and firing of said squib capable of evaluating and setting-up the values of said controlled currents to their operational necessary minimum in such a way that a secure firing of said squib is always guaranteed and at the same time limiting said main supply energy stored within said external storage capacitor to an optimum.

38. (new): A method for controlled operation and secure firing of igniters or squibs, comprising:

providing a power source delivering the main supply energy and external means for storing said main supply energy within an external storage capacitor;

5 providing a high-side and a low-side switching device, connecting said squib to said power source and to ground respectively and thus allowing safely performed diagnostics of switches and said squib and also guaranteeing a secure firing of said squib when simultaneously closed;

10 providing internal means for supplying multiple driver currents to high-side and said low-side switching devices using controllable and switchable current source circuits;

implementing said high-side switching device with the help of a pair of PMOS transistors in current mirror configuration;

15 implementing said low-side switching device with the help of a pair of NMOS transistors in current mirror configuration;

implementing for said high-side and said low-side switching devices a controlled pair of switchable current sources as drivers respectively, whereby in each case one current source defines normal diagnostic and test operations and the other current source guarantees said secure firing; and

20 calculating secure firing current values for said high-side and said low-side switching devices, thereby trimming and setting-up said controlled driving currents to their operational necessary minimum, and thus limiting said main supply energy stored within said external storage capacitor to an optimum.